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Sheet 1 of 1

Complete if Known	
Application Number	10/517,229
Filing Date	12/08/2004
First Named Inventor	Hajime ICHIMURA
Group Art Unit	Unassigned
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U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.[1]	U.S. Patent Document: Number	U.S. Patent Document: Kind Code[2] (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

FOREIGN PATENT DOCUMENTS

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	B1	HIDEO NAKAE et al., "Influence of Graphite Morphology on Fractured Surface in Flake Graphite Cst Iron Measured by Laser Roughness Meter", Chuzo Kogaku, Japan Foundry Engineering Society, 2002, pages 644-649, Vol. 74, No. 10.	

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